

<b>Notice of References Cited</b>	Application/Control No. 10/828,292	Applicant(s)/Patent Under Reexamination SHIMAZAWA ET AL.	
	Examiner Craig A. Renner	Art Unit 2627	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0002229 A1	01-2003	Pinarbasi, Mustafa	360/324.2
*	B	US-2003/0143431 A1	07-2003	Hasegawa, Naoya	428/692
*	C	US-2004/0061986 A1	04-2004	Kagami et al.	360/324.11
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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	P					
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**NON-PATENT DOCUMENTS**

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